

**Search Notes**

Application/Control No.

10/694,598

Examiner

Shih-Chao Chen

Applicant(s)/Patent under  
Reexamination

ASAKURA ET AL.

Art Unit

2821

**SEARCHED**

Class	Subclass	Date	Examiner
343	702, 846, 895, 700MS	6/24/2005	CHEN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (See attached printout)	6/24/2005	CHEN